



ELECTRONICS, INC.
 44 FARRAND STREET
 BLOOMFIELD, NJ 07003
 (973) 748-5089

NTE5631 thru NTE5637 TRIAC – 10 Amp

Description:

The NTE5631 through NTE5637 series of TRIACs are high performance glass passivated PNPN devices in a TO220 type package designed for general purpose applications where moderate gate sensitivity is required.

Absolute Maximum Ratings: ($T_A = +25^\circ\text{C}$ unless otherwise specified)

Repetitive Peak Off-State Voltage ($T_J = -40^\circ$ to $+125^\circ\text{C}$, $R_{GK} = 1\text{k}\Omega$), V_{DRM}		
NTE5631		50V
NTE5632		100V
NTE5633		200V
NTE5634		300V
NTE5635		400V
NTE5636		500V
NTE5637		600V
On-State Current (All Conduction Angles, $T_C = +85^\circ\text{C}$), $I_{T(RMS)}$		10A
Non-Repetitive On-State Current (Half Cycle), I_{TSM}		
60Hz		110A
50Hz		100A
Fusing Current ($t = 10\text{ms}$), I^2t		50A ² s
Peak Gate Current ($t = 10\mu\text{s}$ Max), I_{GM}		4A
Peak Gate Dissipation ($t = 10\mu\text{s}$ Max), P_{GM}		10W
Gate Dissipation ($t = 20\text{ms}$ Max), $P_{G(AV)}$		1W
Operating Junction Temperature Range, T_J		-40° to $+125^\circ\text{C}$
Storage Temperature Range, T_{stg}		-40° to $+125^\circ\text{C}$
Thermal Resistance, Junction-to-Case, R_{thJC}		2.5K/W
Thermal Resistance, Junction-to-Ambient, R_{thJA}		60K/W
Lead Temperature (During Soldering, 1.6mm from case, 10sec max), T_L		$+250^\circ\text{C}$

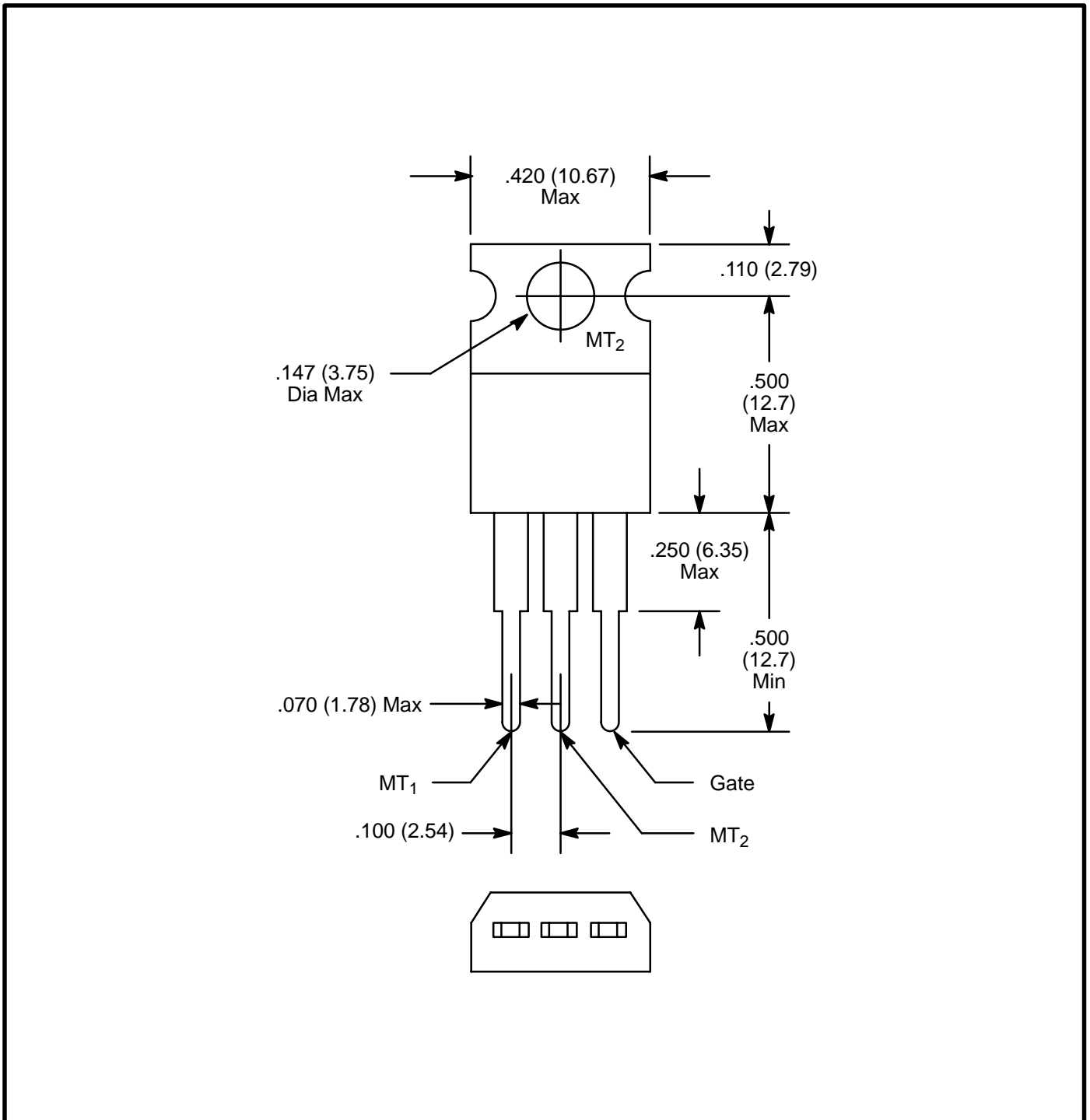
Electrical Characteristics: ($T_A = +25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Off-State Leakage Current	I_{DRM}	$V_D = V_{DRM}$, $R_{GK} = 1\text{k}\Omega$, $T_J = +25^\circ\text{C}$	–	–	10	μA
		$V_D = V_{DRM}$, $R_{GK} = 1\text{k}\Omega$, $T_J = +125^\circ\text{C}$	–	–	2	mA
On-State Voltage	V_T	$I_T = 15\text{A}$, $T_J = +25^\circ\text{C}$	–	–	1.75	V
On-State Threshold Voltage	$V_{T(TO)}$	$T_J = +125^\circ\text{C}$	–	–	1.05	V
On-State Slope Resistance	r_T	$T_J = +125^\circ\text{C}$	–	–	52	m Ω

Electrical Characteristics (Cont'd): ($T_A = +25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Gate Trigger Current	I_{GT}	$V_D = 12\text{V}$, Note 1	–	–	50	mA
Gate Trigger Voltage	V_{GT}	$V_D = 12\text{V}$, All Quadrants	–	–	2.5	V
Holding Current	I_H	$R_{GK} = 1\text{k}\Omega$	–	–	50	mA
Critical Rate-of-Rise	dv/dt	$V_D = 0.67 \times V_{DRM}$, $R_{GK} = 1\text{k}\Omega$, $T_J = +125^\circ\text{C}$	500	–	–	V/ μs
Critical Rate-of-Rise, Off-State	dv/dt_c	$I_T = 8\text{A}$, $di/dt = 3.55\text{A/ms}$, $T_C = +85^\circ\text{C}$	5	–	–	V/ μs

Note 1. For either polarity of gate voltage with reference to electrode MT_1 .



X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for [Triacs](#) category:

Click to view products by [NTE](#) manufacturer:

Other Similar products are found below :

[ACST435-8B](#) [LIC01-215B-TR](#) [T2035H-6G](#) [BT137-600-0Q](#) [Z0410NF 1AA2](#) [098128C](#) [620675E](#) [T1610-600G-TR](#) [Z0409MF0AA2](#)
[Z0109NA 2AL2](#) [ACS108-8SA-AP](#) [ACS108-8SN-TR](#) [ACST1635T-8FP](#) [BCR16PM-12LG#B00](#) [BCR20RM-30LA#B00](#) [T1205-600G-TR](#)
[CMA60MT1600NHR](#) [NTE5611](#) [NTE5612](#) [NTE5613](#) [NTE5621](#) [NTE5623](#) [NTE5629](#) [NTE5638-08](#) [NTE5688](#) [NTE5689](#) [NTE5690](#) [T1235T-](#)
[8I](#) [BTA312-600CT.127](#) [T1210T-8G-TR](#) [T1210T-8G](#) [BT136S-600E,118](#) [BT137B-800G,118](#) [Z0109NN0,135](#) [MAC4DLM-1G](#) [BT137-](#)
[600E,127](#) [BT137X-600D](#) [BT148W-600R,115](#) [BT258-500R,127](#) [BTA08-800BW3G](#) [BTA140-800,127](#) [BTA30-600CW3G](#) [BTA30-600CW3G](#)
[BTB08-800BW3G](#) [BTB16-600CW3G](#) [BTB16-600CW3G](#) [Z0405M-0AA2](#) [Z0410MF0AA2](#) [Z0109MN,135](#) [T825T-6I](#)